

FDW9926A

Dual N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

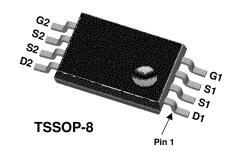
This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V-10V).

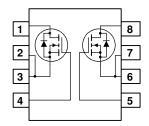
Applications

- Battery protection
- · Load switch
- · Power management

Features

- 4.5 A, 20 V. $R_{DS(ON)} = 32 \ m\Omega \ @ \ V_{GS} = 4.5 \ V$ $R_{DS(ON)} = 45 \ m\Omega \ @ \ V_{GS} = 2.5 \ V$
- Optimized for use in battery circuit applications
- Extended V_{GSS} range (±10V) for battery applications
- $\bullet~$ High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low profile TSSOP-8 package





Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-------------------|--|-----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 20 | V |
| V _{GSS} | Gate-Source Voltage | | ±12 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 4.5 | Α |
| | - Pulsed | | 30 | |
| P _D | Total Power Dissipation | (Note 1a) | 1.0 | W |
| | | (Note 1b) | 0.6 | |
| T_J , T_{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 125 | °C/W |
|-----------------|---|-----------|-----|------|
| | | (Note 1b) | 208 | |

Package Marking and Ordering Information

| Device Marking Device | | Reel Size | Tape width | Quantity | |
|-----------------------|------------------|-----------|------------|------------|--|
| 9926A | 6A FDW9926A 13'' | | 12mm | 2500 units | |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---|---|--|-----|------|------|-------|
| Off Char | acteristics | | 1 | | | 1 |
| BV _{DSS} | Drain–Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$ | 20 | | | V |
| ΔBVDSS | Breakdown Voltage Temperature | | | 40 | | 1400 |
| ΔT_{J} | Coefficient | $I_D = 250 \mu A$, Referenced to 25°C | | 12 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| I _{GSS} | Gate-Body Leakage | $V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |
| On Chara | acteristics (Note 2) | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ | 0.6 | 1.0 | 1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_{,J}}$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | -3 | | mV/°C |
| R _{DS(on)} | Static Drain–Source | $V_{GS} = 4.5 \text{ V}, I_{D} = 4.5 \text{ A}$ | | 24 | 32 | mΩ |
| | On-Resistance | $V_{GS} = 2.5 \text{ V}, \qquad I_D = 3.8 \text{ A}$ | | 34 | 45 | |
| | | $V_{GS} = 4.5 \text{ V}, I_D = 4.5 \text{A}, T_J = 125 ^{\circ}\text{C}$ | | 33 | 48 | |
| $I_{D(on)}$ | On-State Drain Current | $V_{GS} = 4.5 \text{ V}, \qquad V_{DS} = 5 \text{ V}$ | 15 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = 5 V$, $I_{D} = 4.5 A$ | | 19 | | S |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ | | 630 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 150 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 85 | | pF |
| R _G | Gate Resistance | $V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$ | | 1.4 | | Ω |
| Switchin | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 10 \text{ V}, \qquad I_D = 1 \text{ A},$ | | 8 | 16 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 8 | 16 | ns |
| t _{d(off)} | Turn-Off Delay Time | 7 | | 15 | 26 | ns |
| t _f | Turn-Off Fall Time | 7 | | 4 | 8 | ns |
| Q _g | Total Gate Charge | $V_{DS} = 10 \text{ V}, \qquad I_{D} = 4.5 \text{ A},$ | | 6.1 | 9 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = 4.5 V | | 1.1 | | nC |
| Q _{gd} | Gate-Drain Charge | | | 1.8 | | nC |
| Drain-Sc | ource Diode Characteristics a | and Maximum Ratings | | | | • |
| l _s | Maximum Continuous Drain-Source | <u>~</u> | | | 0.83 | Α |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 0.83 \text{ A} \text{(Note 2)}$ | | 0.69 | 1.2 | V |
| t _{rr} | Diode Reverse Recovery Time | $I_F = 4.5 \text{ A},$ | | 14 | | nS |
| Q _{rr} | Diode Reverse Recovery Charge | $d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$ | | 4 | | nC |

^{1.} R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\rm eJC}$ is guaranteed by design while $R_{\rm eCA}$ is determined by the user's board design.

a) $R_{\theta,JA}$ is 125°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4. b) $R_{\theta,JA}$ is 208°C/W (steady state) when mounted on a minimum copper pad on FR-4.

^{2.} Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%

Typical Characteristics

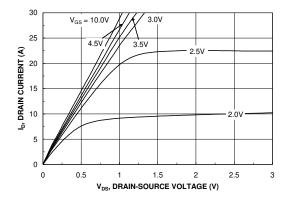


Figure 1. On-Region Characteristics.

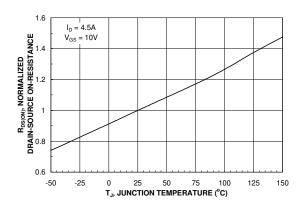


Figure 3. On-Resistance Variation with temperature.

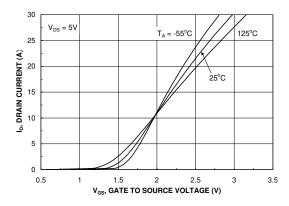


Figure 5. Transfer Characteristics.

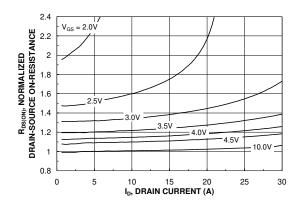


Figure 2. On-Resistance Variation with Drain Current and Gate voltage.

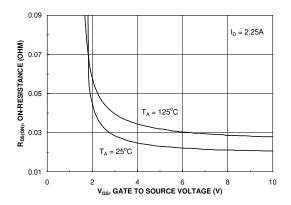


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

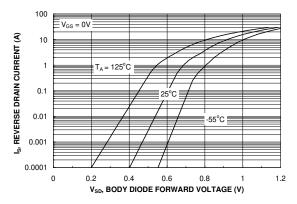
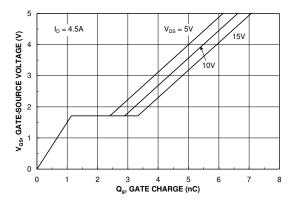


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



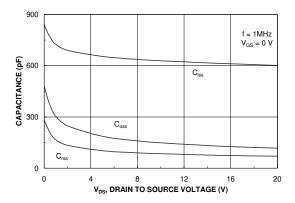
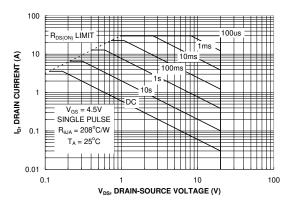


Figure 7. Gate Charge Characteristics.





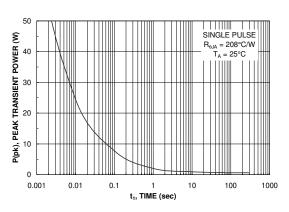


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

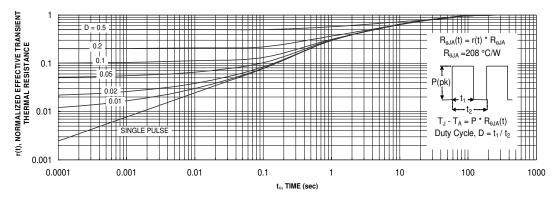


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.





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